

April 1988 Revised September 2000

74F132

Quad 2-Input NAND Schmitt Trigger

General Description

The F132 contains four 2-input NAND gates which accept standard TTL input signals and provide standard TTL output levels. They are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals. In addition, they have a greater noise margin than conventional NAND gates.

Each circuit contains a 2-input Schmitt Trigger followed by level shifting circuitry and a standard FAST™ output struc-

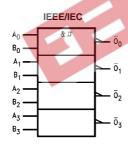
ture. The Schmitt Trigger uses positive feedback to effectively speed-up slow input transitions, and provide different input threshold voltages for positive and negative-going transitions. This hysteresis between the positive-going and negative-going input threshold (typically 800 mV) is determined by resistor ratios and is essentially insensitive to temperature and supply voltage variations.

Ordering Code:

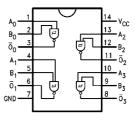
Order Number	Package Number	Package Description
74F132SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F132SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F132PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0,300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code

Logic Symbol



Connection Diagram



Unit Loading/Fan Out

Din Names	December	U.L.	Input I _{IH} /I _{IL}		
riii Naiiles	Description	HIGH/LOW	Output I _{OH} /I _{OL}		
A _n , B _n	Inputs	1.0/1.0	20 μA/–0.6 mA		
\overline{O}_n	Outputs	50/33.3	−1 mA/20 mA		

Function Table

Inputs		Outputs		
Α	В	ō		
L	L	Н		
L	Н	Н		
Н	L	Н		
Н	Н	L		

H = HIGH Voltage Level

FAST® is a registered trademark of Fairchild Semiconductor Corporation

Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

Storage Temperature $-65^{\circ}\text{C} \text{ to } +150^{\circ}\text{C}$

Ambient Temperature under Bias -55° C to +125 $^{\circ}$ C Junction Temperature under Bias -55° C to +150 $^{\circ}$ C

 $\begin{array}{lll} \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Voltage (Note 2)} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Current (Note 2)} & -30 \text{ mA to } +5.0 \text{ mA} \\ \end{array}$

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & -0.5 \text{V to +5.5 V} \end{array}$

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA) ESD Last Passing Voltage (Min) 4000V

Free Air Ambient Temperature $0^{\circ}\text{C} \text{ to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

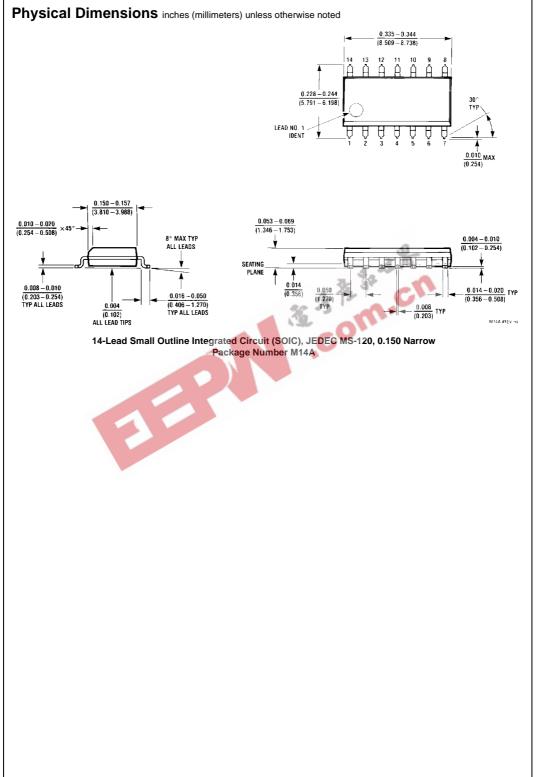
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

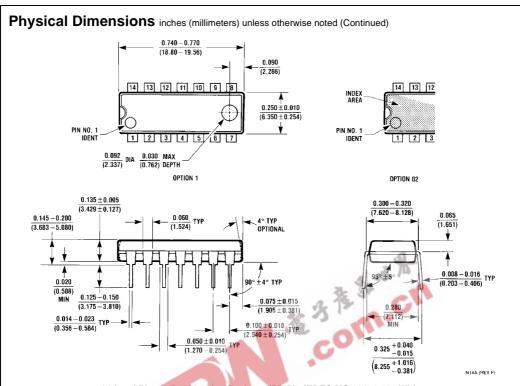
DC Electrical Characteristics

DC LI	ectrical Characteristics	3				- B	
Symbol	Parameter	Min	Тур	Max	Units	V _{CC}	Conditions
V_{T+}	Positive-going Threshold	1.5		2.0	V	5.0	
V_{T-}	Negative-going Threshold	0.7		1.1	4	5.0	
ΔV_{T}	Hysteresis (V _T ⁺ – V _T ⁻)	0.4	40	7	V	5.0	
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH 10% V _{CC}	2.5	-		V	Min	$I_{OH} = -1 \text{ mA}$
	Voltage 5% V _{CC}	2.7					$I_{OH} = -1 \text{ mA}$
V _{OL}	Output LOW Voltage 10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA
I _{IH}	Input HIGH Current			5.0	μΑ	Max	$V_{IN} = 2.7V$
I _{BVI}	Input HIGH Current Breakdown Test			7.0	μΑ	Max	$V_{IN} = 7.0V$
I _{CEX}	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC}$
V _{ID}	Input Leakage Test	4.75			V	0.0	I _{ID} = 1.9 μA All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current			3.75	μА	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IL}	Input LOW Current			-0.6	mA	Max	$V_{IN} = 0.5V$
Ios	Output Short-Circuit Current	-60		-150	mA	Max	V _{OUT} = 0V
I _{CCH}	Power Supply Current			17.0	mA	Max	V _O = HIGH
I _{CCL}	Power Supply Current			18.0	mA	Max	$V_O = LOW$

AC Electrical Characteristics

Symbol	Parameter	$T_A = +25$ °C $V_{CC} = +5.0V$ $C_1 = 50 \text{ pF}$			T _A = 0°C	Units	
					V _{CC} = +5.0V C ₁ = 50 pF		
		Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay	4.0		10.5	3.5	12.0	no
t _{PHI}	A_n , B_n to \overline{O}_n	5.0		12.5	5.0	13.0	ns





14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com